

Notice of References Cited	Application/Control No. 10/500,748		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner WU-CHENG Winston SHEN		Art Unit 1632	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0120400	06-2005	Day et al.	800/017
*	B	US-5,576,201	11-1996	Mason et al.	435/456
*	C	US-2003/0092070	05-2003	Zhao et al.	435/7.2
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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